


<b>Search Notes</b> 	<b>Application/Control No.</b> 10584890	<b>Applicant(s)/Patent Under Reexamination</b> SHIN CHIN ET AL.
	<b>Examiner</b> DAVID B LUGO	<b>Art Unit</b> 2611

SEARCHED			
Class	Subclass	Date	Examiner
375	140-142, 147, 148, 260, 267	3/17/09	DL

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search, East search	3/17/09	DL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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